

Notice of References Cited	Application/Control No. 10/829,148	Applicant(s)/Patent Under Reexamination MALIK, ROGER J.	
	Examiner Richard Bueker	Art Unit 1763	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,195,071	03-1940	BAHNEY LUTHER W; et. al.	164/450.1
*	B	US-2,508,500	05-1950	DE LANGE CORNELIS; et. al.	118/718
*	C	US-2,568,578	09-1951	BENNETT FOSTER C	392/478
*	D	US-3,400,241	09-1968	GLOERSEN PER; et. al.	219/628
*	E	US-3,634,647	01-1972	Dale, Jr., Ernest Brock	219/121.15
*	F	US-4,112,137	09-1978	Zega, Bogdan	427/529
*	G	US-4,606,296	08-1986	Gailliard et al.	118/726
*	H	US-5,031,229	07-1991	Chow, Loren A.	392/389
*	I	US-5,407,000	04-1995	Mercer et al.	164/457
*	J	US-5,507,854	04-1996	Yamada et al.	75/387
*	K	US-5,558,720	09-1996	Sarraf et al.	118/726
*	L	US-2004/0026234	02-2004	Vanden Brande et al.	204/192.12
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 53-019135	02-1978	Japan	Komiyama	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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